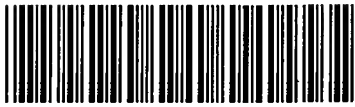


<b>Search Notes</b>  	<b>Application/Control No.</b>  10506468	<b>Applicant(s)/Patent Under Reexamination</b>  MCLAUGHLIN ET AL.
	<b>Examiner</b>  Yeh, Eueng-nan	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
(382/171) text search - see search outputs	2007/12/12	ey
EAST text serach - see search outputs	2007/10/12	ey
PALM inventor search - see search outputs	2007/10/12	ey
USPTO PLUS search - see search outputs	2007/12/10	ey
(382/128) text search - see search outputs (consulted A. Johns A.U. 2624)	2007/12/18	ey

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner